

## 1.Features

- $V_{DS(V)} = -40V$
- $R_{DS(ON)} < 12.3m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 18m\Omega (V_{GS} = -4.5V)$
- RoHS Compliant
- High performance trench technology for extremely low  $R_{DS(ON)}$

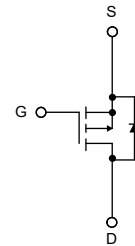
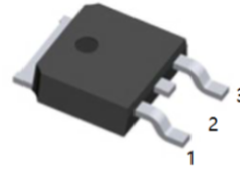
## 2.Applications

- Inverter
- Power Supplies

## 3.Pinning information

Pin	Symbol	Description
1	G	GATE
2	D	DRAIN
3	S	SOURCE

TO-252(DPAK)  
top view



## 4.Absolute Maximum Ratings $T_c = 25^\circ C$

Parameter	Symbol	Rating	Units
Drain to Source Voltage	$V_{DS}$	-40	V
Gate to Source Voltage	$V_{GS}$	$\pm 20$	
Drain Current -Continuous (Package limited) $T_c = 25^\circ C$	$I_D$	-50	A
-Continuous (Silicon limited) $T_c = 25^\circ C$		-58	
-Continuous $T_A = 25^\circ C$ (Note 1a)		-10.8	
-Pulsed		-100	
Single Pulse Avalanche Energy (Note 3)	$E_{AS}$	337	mJ
Power Dissipation $T_c = 25^\circ C$	$P_D$	69	W
Power Dissipation $T_A = 25^\circ C$ (Note 1a)		2.4	
Operating and Storage Junction Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ C$



## 5. Thermal Characteristics

Parameter	Symbol	Rating	Units
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.8	°C/W
Thermal Resistance, Junction to Ambient (Note 1a)	$R_{\theta JA}$	52	°C/W



## 6. Electrical Characteristic (T<sub>J</sub>=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units	
<b>Off Characteristics</b>							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	-40			V	
Breakdown Voltage Temperature Coefficient	$\frac{\Delta BV_{DSS}}{\Delta T_J}$	I <sub>D</sub> =-250μA Referenced to 25°C		-29		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-32V			-1	μA	
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA	
<b>On Characteristics</b>							
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-1	-1.8	-3	V	
Gate to Source Threshold Voltage Temperature Coefficient	$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	I <sub>D</sub> =-250μA Referenced to 25°C		5.8		mV/°C	
Static Drain to Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-12.7A		10.1	12.3	mΩ	
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10.4A		14.5	18	mΩ	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =-5V, I <sub>D</sub> =-12.7A		38		S	
<b>Dynamic Characteristics</b>							
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V, f=1MHz		2085	2775	pF	
Output Capacitance	C <sub>oss</sub>			360	480	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			210	310	pF	
Gate Resistance	R <sub>g</sub>	f=1MHz		4.6		Ω	
<b>Switching Characteristics</b>							
Turn-On DelayTime	t <sub>D(on)</sub>	V <sub>DD</sub> =-20V, I <sub>D</sub> =-12.7A V <sub>GS</sub> =-10V, R <sub>GEN</sub> =6Ω		10	19	ns	
Rise Time	t <sub>r</sub>			7	13	ns	
Turn-Off DelayTime	t <sub>D(off)</sub>			38	60	ns	
Fall Time	t <sub>f</sub>			15	27	ns	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =0V to -10V	V <sub>DD</sub> =-20V I <sub>D</sub> =-12.7A		36	50	nC
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =0V to -5V			19	27	nC
Gate to Source Charge	Q <sub>gs</sub>			7		nC	
Gate to Drain "Miller" Charge	Q <sub>gd</sub>			8		nC	

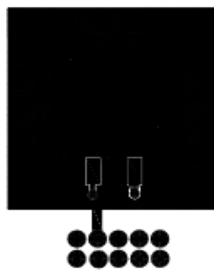


Drain-Source Diode Characteristics						
Source to Drain Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_S=-12.7A$ (Note 2)		-0.8	-1.2	V
Reverse Recovery Time	$t_{rr}$	$I_F=-12.7A, di/dt=100A/\mu s$		29	44	ns
Reverse Recovery Charge	$Q_{rr}$			26	40	nC

Notes:

1:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.

$R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a) 52°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 100°C/W when mounted on a minimum pad.

2: Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

3: Starting  $T_J=25^\circ C, L=3mH, I_{AS}=15A, V_{DD}=40V, V_{GS}=10V$ .



## 7.1 Typical characteristic

<p>Figure 1: On-Region Characteristics</p>	<p>Figure 2: Normalized On-Resistance vs Drain Current and Gate Voltage</p>
<p>Figure 3: Normalized On Resistance vs Junction Temperature</p>	<p>Figure 4: On-Resistance Variation with Gate-to-Source Voltage</p>
<p>Figure 5: Transfer Characteristics</p>	<p>Figure 6: Source to Drain Diode Forward Voltage vs Source Current</p>

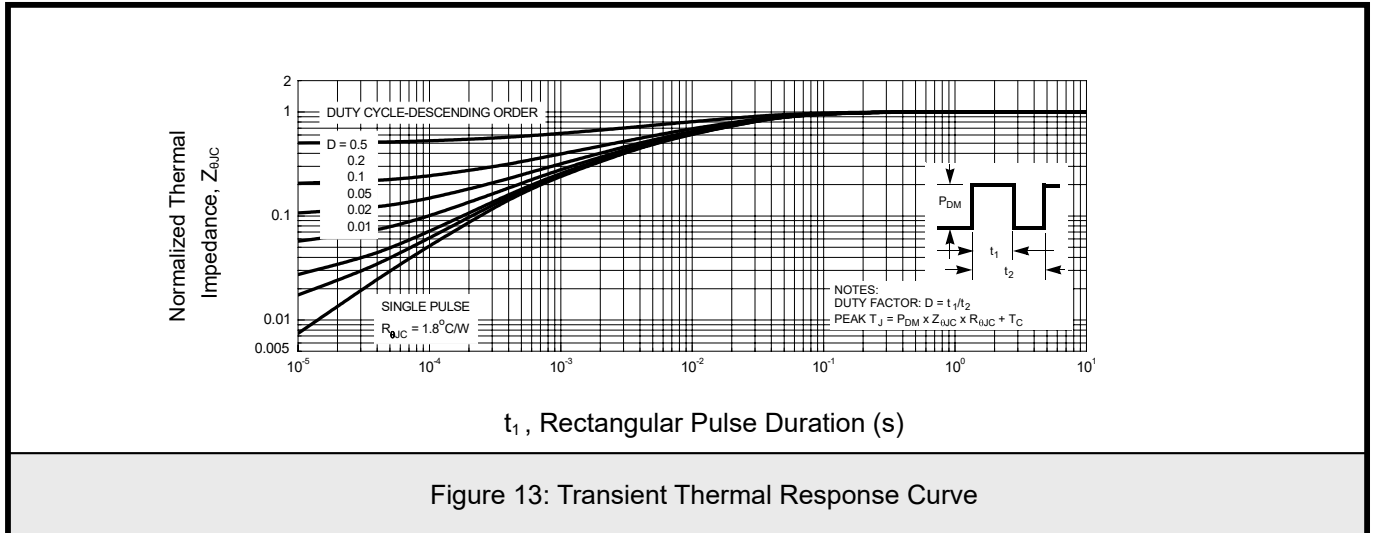


## 7.2 Typical characteristic

<p style="text-align: center;"><math>-V_{GS}</math>, Gate To Source Voltage (V)</p> <p style="text-align: center;"><math>Q_g</math>, Gate Charge (nC)</p>	<p style="text-align: center;">Capacitance (pF)</p> <p style="text-align: center;"><math>-V_{DS}</math>, Drain To Source Voltage (V)</p>
<p style="text-align: center;">Figure 7: Gate Charge Characteristics</p>	<p style="text-align: center;">Figure 8: Capacitance vs Drain to Source Voltage</p>
<p style="text-align: center;"><math>-I_{AS}</math>, Avalanche Current(A)</p> <p style="text-align: center;"><math>t_{AV}</math>, Time In Avalanche(ms)</p>	<p style="text-align: center;"><math>-I_D</math>, Drain Current (A)</p> <p style="text-align: center;"><math>T_C</math>, Case Temperature (<math>^{\circ}C</math>)</p>
<p style="text-align: center;">Figure 9: Unclamped Inductive Switching Capability</p>	<p style="text-align: center;">Figure 10: Maximum Continuous Drain Current vs Case Temperature</p>
<p style="text-align: center;"><math>-I_D</math>, Drain Current (A)</p> <p style="text-align: center;"><math>-V_{DS}</math>, Drain To Source Voltage (V)</p>	<p style="text-align: center;"><math>P_{PK}</math>, Peak Transient Power (W)</p> <p style="text-align: center;"><math>t</math>, Pulse Width (s)</p>
<p style="text-align: center;">Figure 11: Forward Bias Safe Operating Area</p>	<p style="text-align: center;">Figure 12: Single Pulse Maximum Power Dissipation</p>

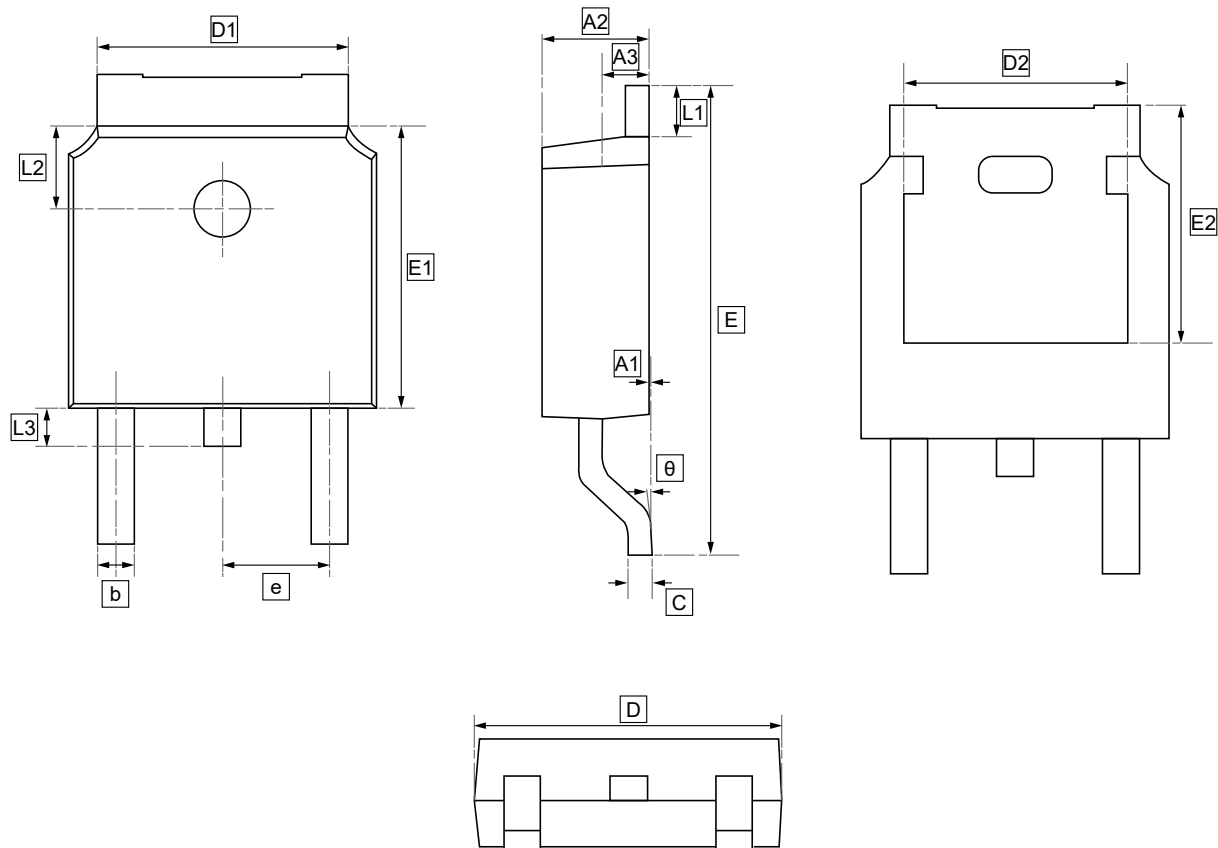


## 7.3 Typical characteristic





## 8.TO-252 Package Outline Dimensions

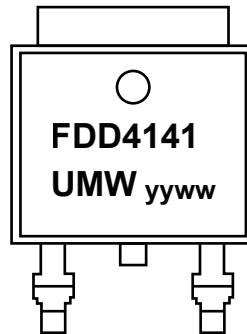


### DIMENSIONS (mm are the original dimensions)

Symbol	A1	A2	A3	b	c	D	D1	D2	E	E1	E2	e	L1	L2	L3	θ
<b>Min</b>	0.00	2.18	0.90	0.65	0.46	6.35	4.95	4.32	9.40	5.97	5.21	2.286	0.89	1.70	0.60	0.00
<b>Max</b>	0.13	2.39	1.10	0.85	0.61	6.73	5.46	4.90	10.41	6.22	5.38	BSC	1.27	1.90	1.00	8.00



## 9. Ordering information



yy: Year Code  
ww: Week Code

Order Code	Package	Base QTY	Delivery Mode
UMW FDD4141	TO-252	2500	Tape and reel



## 10.Disclaimer

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